# Development of DLC dopped with B using trimethyl borate as precursor

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**Abstract:** In this work, we developed a B-DLC by PECVD using TMB as a precursor at a low treatment temperature. The precursor added to the treatment introduced boron and oxygen in the film due to the precursor composition, influencing the structure and hardness behavior of the film.

#### 1. Introduction

DLC doped with boron (B-DLC) has interesting properties such as better sanguine compatibility, physical stability, high thermal resistance, lower internal tension, low friction coefficient, and better electrical conductivity [1]. However, its industrial production is limited due to the toxic, explosive, and poisonous precursors used in this process, as for example, B<sub>2</sub>H<sub>6</sub>, BF<sub>3</sub>, and BCl<sub>3</sub>. The trimethyl borate (TMB, B(CH<sub>3</sub>O)<sub>3</sub>) is an alternative to this process, once it is cheap, a highly volatile, nontoxic, and non-explosive organic liquid [2, 3].

Therefore, a comprehensive study needs to be carried out to develop the treatment using the TMB as a precursor and determine the effectiveness of adding boron to the properties of the DLC films.

#### 2. Methods

The DLC and B-DLC films were deposited on a titanium substrate by PECVD using a pulsed DC-power supply in three steps, starting with an ablation process using 80% Ar and 20% H<sub>2</sub> for 1 h, followed by the deposition of the organosilicon interlayer using 70% HMDSO and 30% Ar for 15 min, and ending with the film deposition. The DLC film was deposited using 0.27 torr of CH<sub>4</sub> and 0.03 torr of Ar for 2 h. The B-DLC films were deposited using the parameters defined in Table 1.

**Table 1.** Parameters of B-DLC films deposition

	Pressure (torr)			Temperature (°C)
	CH <sub>4</sub>	Ar	TMB	
			0,025	
500	0.27	0.03	0,05	200 - 105
V			0,075	
			0,025	
550	0.27	0.03	0,05	200 - 110
V			0,075	
			0,025	
600	0.027	0.03	0,05	200 - 125
V			0,075	

### 3. Results and Discussion

It is possible to observe from WDS by SEM analysis that the DLC film showed a percentage of the oxygen content of 0.6% wt, while the B-DLC film showed a percentage of the oxygen content of 14.3 % wt, 13.6 % wt, and 5 % wt for 500V, 550V, and 600V respectively, independent of TBM quantity added to the treatment. The higher percentage of oxygen and lower presence of boron promoted a less hard film formation, while the lower percentage of oxygen and higher presence of boron promoted a harder film formation (Figure 1).

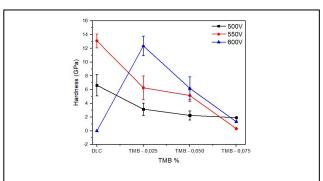


Fig. 1. Nanohardness result for the DLC and B-DLC

The spectra obtained from FTIR analyses (Fourier Transform Infrared Spectroscopy) showed the formation of B-C or C-C bond in 1100-1280 cm<sup>-1</sup> for the 0.025 torr of TMB, and the formation of B-B-C bond in 1570 cm<sup>-1</sup> for the 0.075 torr of TMB, independent of the tension applied in the treatment.

# 4. Conclusion

It was possible to dope the DLC film with boron using a TMB as a precursor. The presence of oxygen and boron content influenced the hardness of the films. The higher amount of TMB was more promising in doping the film.

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## References

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